

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S82	4136	382/103,151,209,210,211,216,217,218,219,220,221,222.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/18 05:39
S83	353	382/103,151,209,210,211,216,217,218,219,220,221,222.ccls. and score	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/18 05:39
S84	185	382/103,151,209,210,211,216,217,218,219,220,221,222.ccls. and (score with match\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/18 05:43
S85	11	382/103,151,209,210,211,216,217,218,219,220,221,222.ccls. and (score with match\$4 with orientation)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/18 06:42
S86	1	382/103,151,209,210,211,216,217,218,219,220,221,222.ccls. and (score with match\$4 with intensity)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/18 08:07
S87	0	382/103,151,209,210,211,216,217,218,219,220,221,222.ccls. and (score with match\$4 with intensity)and (attitude or pitch or yaw)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/18 08:08
S88	15	382/103,151,209,210,211,216,217,218,219,220,221,222.ccls. and (score with match\$4)and (attitude or pitch or yaw)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/18 08:13
S89	17	382/103,151,209,210,211,216,217,218,219,220,221,222.ccls. and (score with match\$4)and (attitude or pitch or yaw or roll)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/19 07:41

S90	755	(score with match\$4)and (attitude or pitch or yaw or roll)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/18 08:13
S91	3	(score with match\$4 with intensity)and (attitude or pitch or yaw or roll)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/18 08:36
S92	0	boolean near2 bitwiswe with compar\$4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/18 08:37
S93	3	boolean near2 bitwise with compar\$4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/18 08:40
S94	23	morphological near2 filter\$4 with intensity	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/18 08:41
S95	1	"6640088".pn.	USPAT	OR	OFF	2005/05/18 12:41
S96	1	"6640008".pn.	USPAT	OR	OFF	2005/05/18 12:41
S97	23	("4402053" "4473883" "4644585" "4654872" "4707647" "4712248" "4845765" "4876728" "4982438" "5040231" "5173946" "5220615" "5249035" "5263098" "5351310" "5422962" "5809171").PN. OR ("6173066"). URPN.	US-PGPUB; USPAT; USOCR	OR	OFF	2005/05/19 06:18

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L1	18	382/103,151,209,210,211,216,217,218,219,220,221,222.ccls. and (score with (match\$4 or fit))and (attitude or pitch or yaw or roll)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/19 07:42
L2	271	382/103,151,209,210,211,216,217,218,219,220,221,222.ccls. and ((match\$4 or fit))and (attitude or pitch or yaw or roll)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/19 07:42
L3	54	382/103,151,209,210,211,216,217,218,219,220,221,222.ccls. and ((match\$4 or fit))and (attitude)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/19 07:43
L4	30	382/103,151,209,210,211,216,217,218,219,220,221,222.ccls. and ((match\$4 or fit))and (attitude) and (intensity or gray)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/19 07:56
L5	2365	((match\$4 or fit))and (attitude) and (intensity or gray)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/19 07:56
L6	66	((match\$4 or fit))same (attitude) same (intensity or gray)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/19 07:57
L7	20	((match\$4 or fit))same (attitude) same (intensity or gray)same image	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/19 08:38
L8	2	weismuller and attitude	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/19 08:02

L9	351	((match\$4 or fit))same (attitude or orientat\$4) same (intensity or gray)same image	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/19 08:38
L10	488	((match\$4 or fit))same (attitude or orient\$6) same (intensity or gray)same image	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/19 08:39
L11	34	((match\$4 or fit))with (attitude or orient\$6) with (intensity or gray)with image	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/19 08:39

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L13	1006	382/155-161.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/19 08:57
L14	430	382/155-161.ccls. and (match or fit)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/19 08:57
L15	23	382/155-161.ccls. and (match or fit)with (attitude or orient\$6)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/19 08:58


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